

80V N-Channel Enhancement Mode MOSFET

Voltage	80 V	R_{DS(ON)}	5.5 mΩ
Current	108 A	Q_G (TYP)	65.8 nC

Feature:

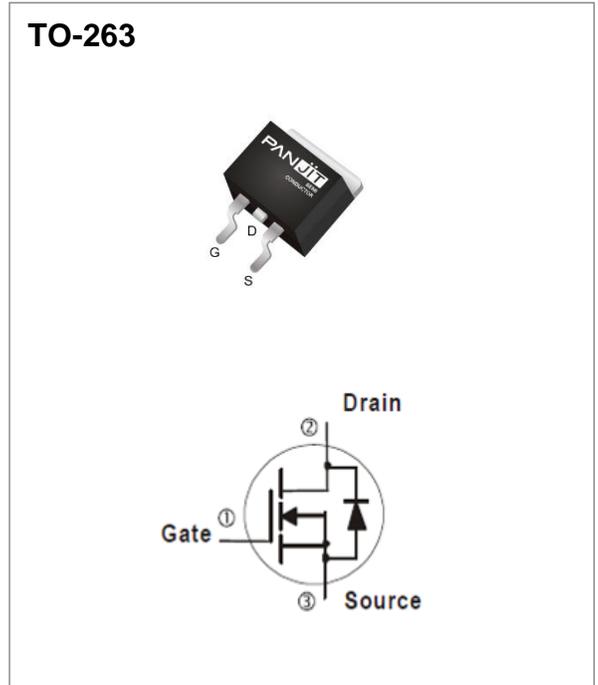
- R_{DS(ON)}, V_{GS}@10V, I_D@50A<5.5mΩ
- R_{DS(ON)}, V_{GS}@7V, I_D@25A<7mΩ
- 100% Avalanche Tested
- 100% Rg Tested
- Lead free in compliance with EU RoHS 2.0
- Green molding compound as per IEC 61249 standard

Mechanical Data

- Case: TO-263 package
- Terminals: Solderable per MIL-STD-750, Method 2026
- Approx. Weight: 1.38 grams

Application

- BMS, BLDC, SMPS SR.



Absolute Maximum Ratings (T_A = 25 °C unless otherwise specified)

PARAMETER	SYMBOL	LIMIT	UNITS
Drain-Source Voltage	V _{DS}	80	V
Gate-Source Voltage	V _{GS}	±20	
Continuous Drain Current ^(Note 3)	I _D	T _C =25°C	108
		T _C =100°C	68
Pulsed Drain Current	I _{DM}	360	A
Single Pulse Avalanche Current ^(Note 5)	I _{AS}	29.6	A
Single Pulse Avalanche Energy ^(Note 5)	E _{AS}	438	mJ
Power Dissipation	P _D	T _C =25°C	113.6
		T _C =100°C	45.5
Operating Junction and Storage Temperature Range	T _J , T _{STG}	-55~150	°C

Thermal Characteristics

PARAMETER	SYMBOL	MAXIMUM	UNITS
Thermal Resistance	Junction-to-Case	1.1	°C/W
	Junction-to-Ambient ^(Note 4)	62.5	°C/W

Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNITS
Static						
Drain-Source Breakdown Voltage	BV_{DSS} ^(Note 7)	$V_{GS}=0V, I_D=250\mu A$	80	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.25	3.1	3.75	
Drain-Source On-State Resistance (Note 1)	$R_{DS(on)}$	$V_{GS}=10V, I_D=50A$	-	3.9	5.5	m Ω
		$V_{GS}=7V, I_D=25A$	-	4.5	7	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=80V, V_{GS}=0V$	-	-	1	μA
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 20V, V_{DS}=0V$	-	-	± 100	nA
Dynamic (Note 6)						
Total Gate Charge	Q_g	$V_{DS}=40V, I_D=50A,$ $V_{GS}=7V$	-	48	-	nC
		$V_{DS}=40V, I_D=50A,$ $V_{GS}=10V$	-	65.8	-	
Gate-Source Charge	Q_{gs}		-	22.4	-	
Gate-Drain Charge	Q_{gd}	-	12.9	-		
Input Capacitance	C_{iss}	$V_{DS}=40V, V_{GS}=0V,$ $F=1MHz$	-	4773	-	pF
Output Capacitance	C_{oss}		-	948	-	
Reverse Transfer Capacitance	C_{rss}		-	42	-	
Turn-On Delay Time	$t_{d(on)}$	$V_{DD}=40V, I_D=50A,$ $V_{GS}=10V, R_G=2\Omega$ (Note 2)	-	44	-	ns
Turn-On Rise Time	t_r		-	108	-	
Turn-Off Delay Time	$t_{d(off)}$		-	73	-	
Turn-Off Fall Time	t_f		-	116	-	
Gate Resistance	R_g	$f=1.0MHz$	-	2.3	-	Ω
Drain-Source Diode						
Diode Forward Voltage	V_{SD}	$I_S=50A, V_{GS}=0V$	-	0.9	1.2	V
Reverse Recovery Charge	Q_{rr}	$I_S=50A$	-	73.3	-	nC
Reverse Recovery Time	T_{rr}	$di/dt=100A/\mu s$	-	56	-	ns

NOTES :

1. Pulse width < 580 μs .
2. Essentially independent of operating temperature typical characteristics.
3. The maximum current rating is silicon limited.
4. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. Mounted on a 1 inch² with 2oz. square pad of copper.
5. The test condition is $L=1mH, I_{AS}=29.6A, V_{DD}=40V, V_{GS}=10V, R_G=25\Omega$, Starting $T_J=25^\circ\text{C}$
6. Guaranteed by design, not subject to production testing.
7. BV_{DSS} is over 85V during mass production.

TYPICAL CHARACTERISTIC CURVES

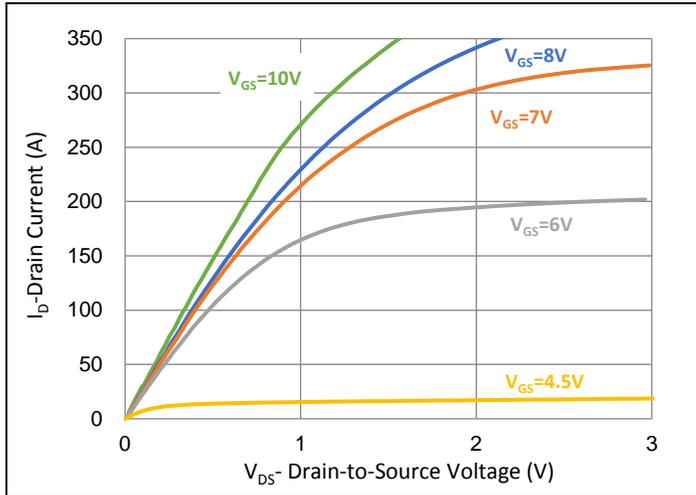


Fig.1 Output Characteristics

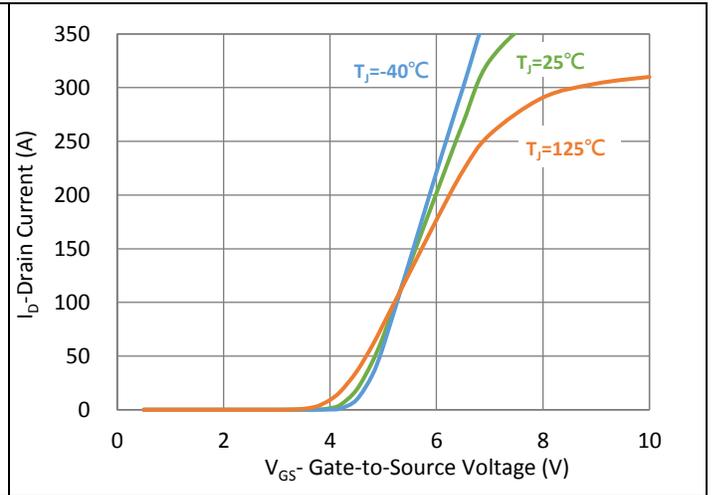


Fig.2 Transfer Characteristics

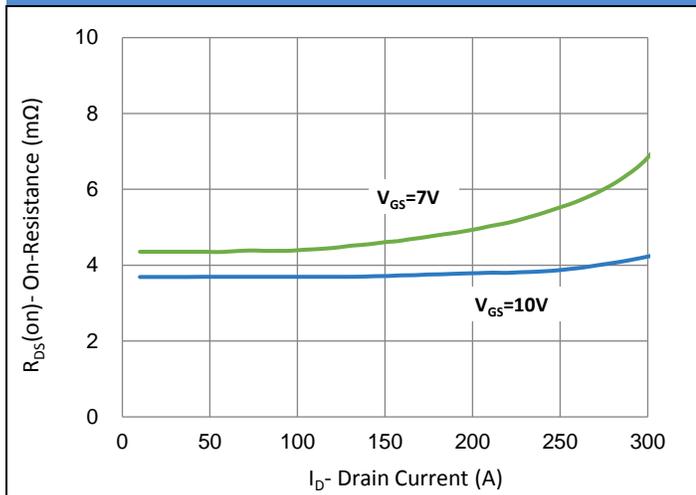


Fig.3 On-Resistance vs. Drain Current

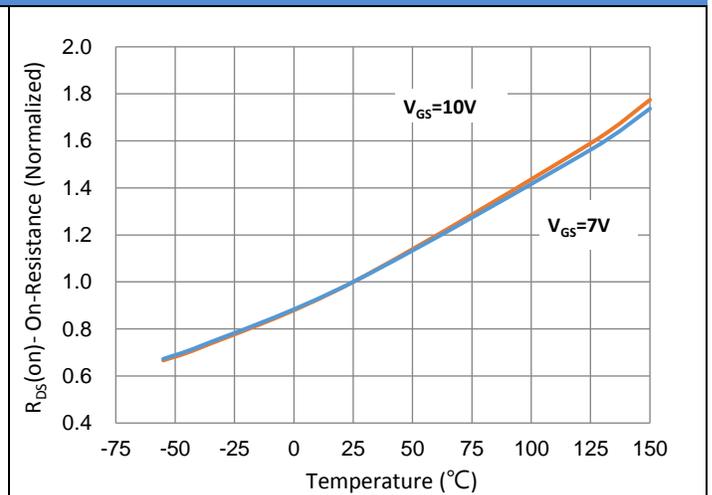


Fig.4 On-Resistance vs. Junction Temperature

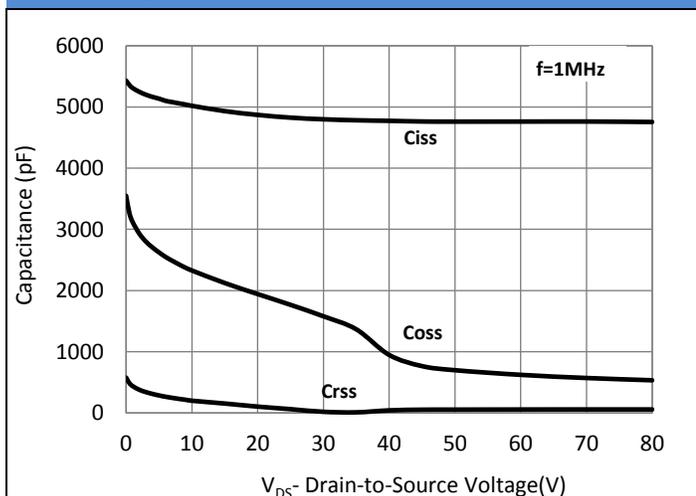


Fig.5 Capacitance vs. Drain-Source Voltage

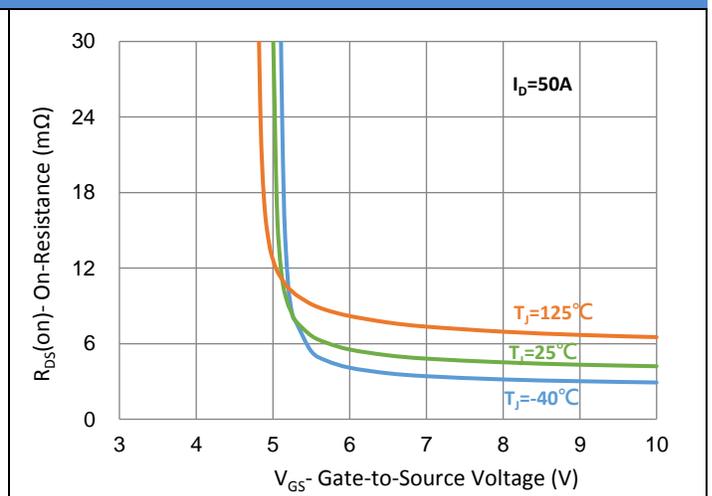


Fig.6 On-Resistance vs. Gate-Source Voltage

TYPICAL CHARACTERISTIC CURVES

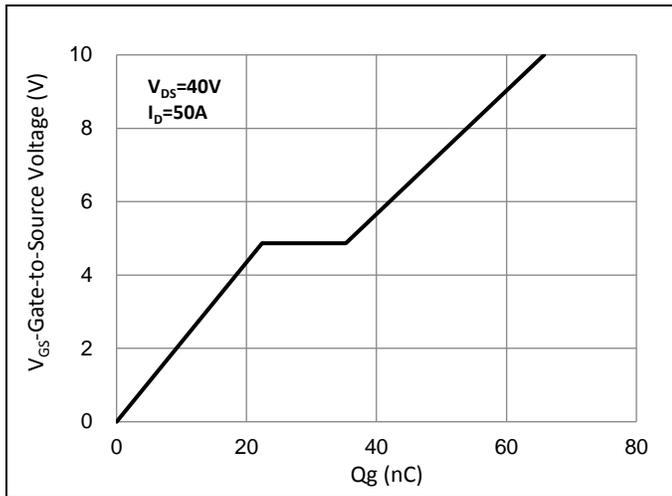


Fig.7 Gate-Charge Characteristics

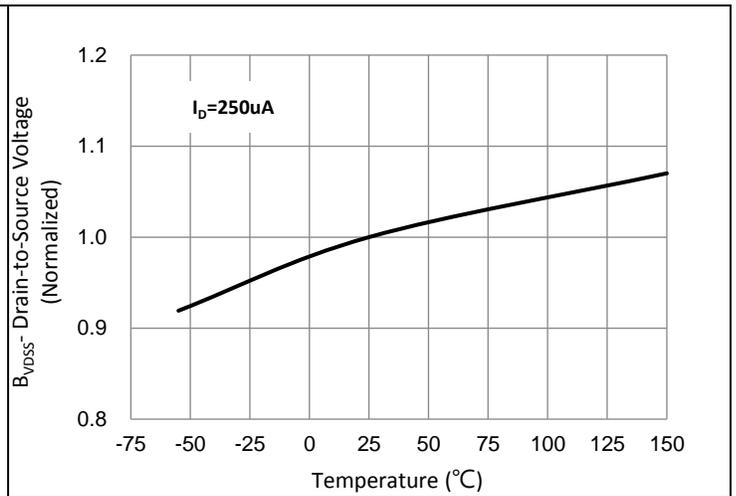


Fig.8 Breakdown Voltage Variation vs. Temperature

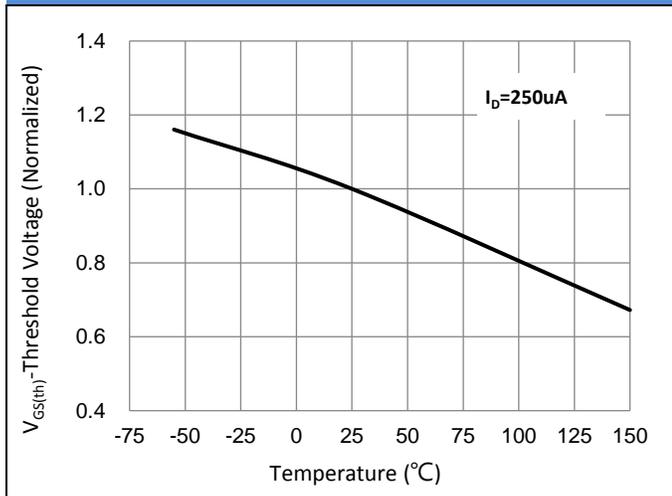


Fig.9 Threshold Voltage Variation with Temperature

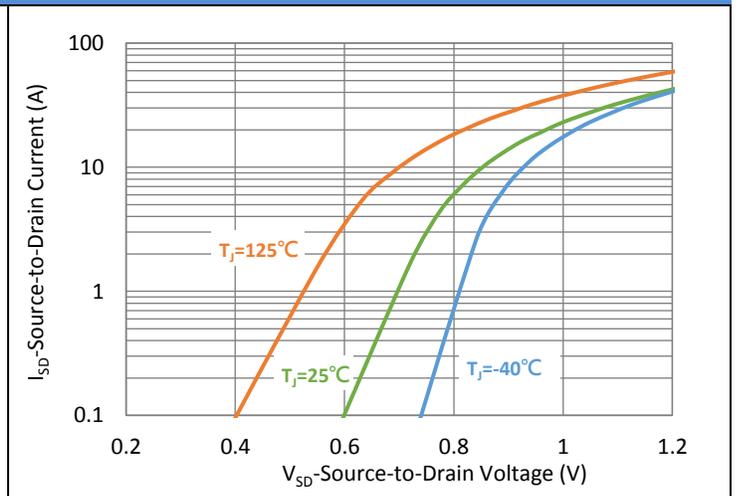


Fig.10 Source-Drain Diode Forward Voltage

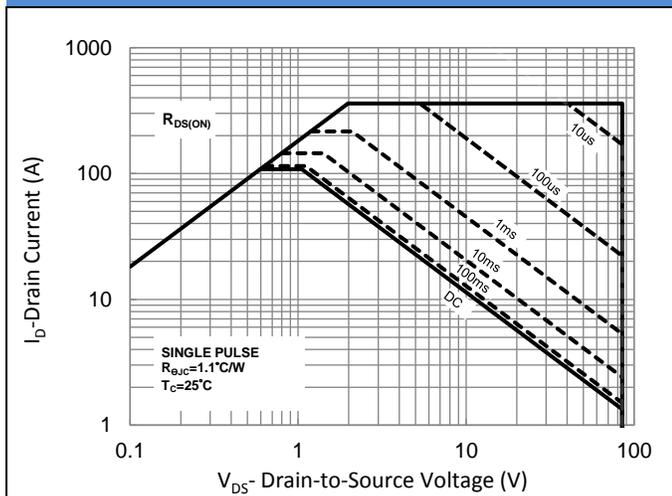


Fig.11 Maximum Safe Operating Area

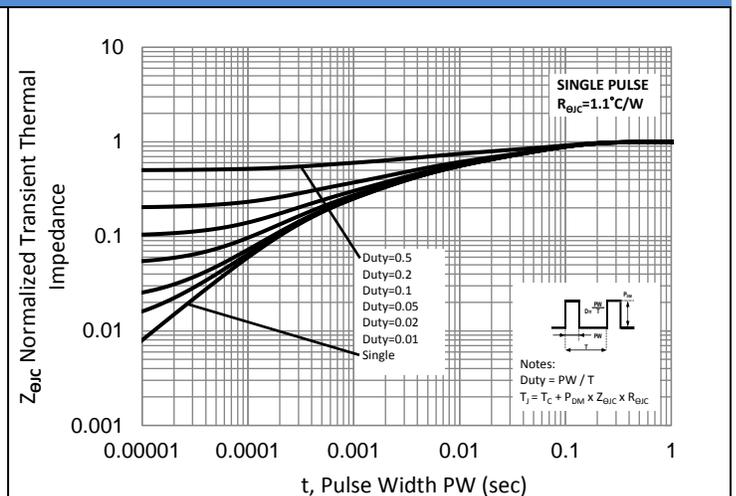


Fig.12 Normalized Transient Thermal Impedance

TYPICAL CHARACTERISTIC CURVES

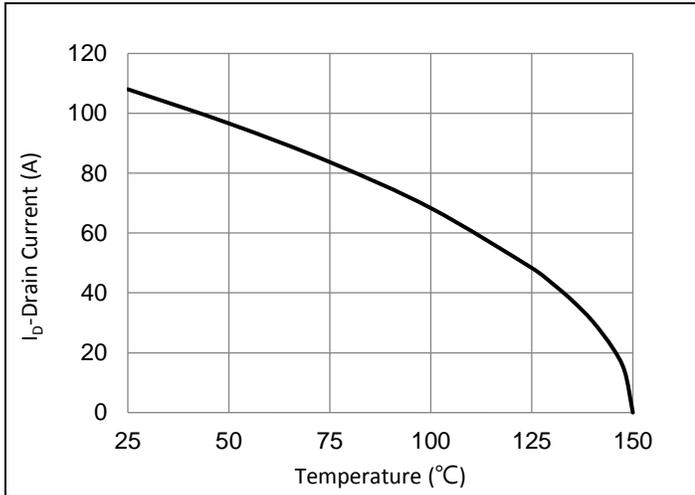


Fig.13 Drain Current vs. Case Temperature

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